Semiconductor Device Test Set - Page 1 of 2



View Online at https://aerobasegroup.com/nsn/6625-00-902-9562

Width:	
5.500 inches	
Length:	
8.000 inches	
Dc Voltage Rating:	
1.6 volts	
Major Components:	
Cable assembly device; lead, te	est; adapter, crystal socket
Accessory Component Quant	tity:
1 and 1 and 1	
Accessory Controlling Agence	:y:
Abbey electronics corporation a	and abbey electronics corporation and abbey electronicscorp
Accessory Identifying Numbe	er:
A2262006 part no. And a22620	007 part no. And a2202047 part no.
Joint Electronics Type Design	nation System Item Name:
Test set, semiconductor device	
Joint Electronics Type Design	nation System Item Type Number:
Type no. Ts-2086/u	
Internal Battery Accommodat	tion:
Included	
Material And Location:	
Plastic housing	
Inclosure Feature:	
Single item w/housing	
Test Type For Which Designe	ed:
Incircuit - saturation voltage and	d resistance of transistors, diode and scr forwatd, characteristics out-of-circuit, saturation voltage and
resistance of transistors, diode	and scr forward, charactereistics, transistor current gain, transistor leakage current, reverse characteristics of
diodes and scrs	
Operating Test Capability:	
Saturation voltage - 0.3v, 0-3v s	saturation resistance -0-10 x1, x10, x100, collector test current - 2.5, 25, 250 ma reverse leakage current -
0-30, va, 0.3 ma, 0-30ma, 0-30	0 ma, current grain, beta - 1-30, 10-300, accuracy - porm 5 pct in-circuit, porm 3 pct out-of-circuit
Height:	

Height:

5.750 inches

Surface Treatment:

Paint

Surface Treatment:

Paint

Fsc Application Data:

Electrical and electronic properties measuring and testing instruments

Shelf Life:

N/a

Unit Of Measure:

NIO

Demilitarization:

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